

FAMILY OF 880-nA/Ch RAIL-TO-RAIL INPUT/OUTPUT OPERATIONAL AMPLIFIERS WITH REVERSE BATTERY PROTECTION

Check for Samples: TLV2401-Q1 , TLV2402-Q1, TLV2404-Q1

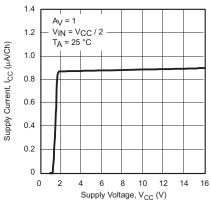
FEATURES

- Qualified for Automotive Applications
- Micro-Power Operation . . . <1 µA/Channel
- Input Common-Mode Range Exceeds the Rails . . . -0.1 V to V_{CC} + 5 V
- Reverse Battery Protection Up To 18 V
- · Rail-to-Rail Input/Output
- Gain Bandwidth Product . . . 5.5 kHz
- Supply Voltage Range . . . 2.5 V to 16 V
- Specified Temperature Range: -40°C to 125°C
- Ultrasmall Packaging
 - 5-Pin SOT-23 (TLV2401-Q1)
 - 8-Pin MSOP (TLV2402-Q1)
- Universal OpAmp EVM (Refer to the EVM Selection Guide SLOU060)

Operational Amplifier



SUPPLY CURRENT vs SUPPLY VOLTAGE



DESCRIPTION/ORDERING INFORMATION

The TLV240x family of single-supply operational amplifiers has the lowest supply current available today at only 880 nA per channel. Reverse battery protection guards the amplifier from an overcurrent condition due to improper battery installation. For harsh environments, the inputs can be taken 5 V above the positive supply rail without damage to the device.

The low supply current is coupled with extremely low input bias currents enabling them to be used with mega-W resistors making them ideal for portable, long active life, applications. DC accuracy is ensured with a low typical offset voltage as low as 390 μ V, CMRR of 120 dB and minimum open loop gain of 130 V/mV at 2.7 V.

The maximum recommended supply voltage is as high as 16 V and ensured operation down to 2.5 V, with electrical characteristics specified at 2.7 V, 5 V and 15 V. The 2.5-V operation makes it compatible with Li-lon battery-powered systems and many micro-power microcontrollers available today including Tl's MSP430.

All members are available in PDIP and SOIC with the singles in the small SOT-23 package, duals in the MSOP, and quads in TSSOP.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





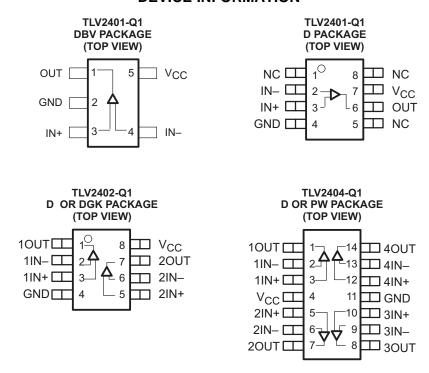
These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

SELECTION OF SINGLE SUPPLY OPERATIONAL AMPLIFIER PRODUCTS (1)(2)

DEVICE	V _{CC} (V)	V _{IO} (mV)	BW (MHz)	SLEW RATE (V/µs)	I _{CC/ch} (μ A)	RAIL-TO-RAIL	
TLV240x-Q1 (2)	2.5–16	0.390	0.005	0.002	0.880	I/O	

- (1) All specifications are typical values measured at 5 V.
- (2) This device also offers 18-V reverse battery protection and 5-V over-the-rail operation on the inputs.

DEVICE INFORMATION



NC - No internal connection

ORDERING INFORMATION(1)

T _A	PACI	(AGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
	MSOP - DGK	Reel of 2500	TLV2402QDGKRQ1	QWX		
			TLV2401QDRQ1			
4000 1- 40500	SOIC - D	Reel of 2500	TLV2402QDRQ1	Product Preview		
–40°C to 125°C			TLV2404QDRQ1			
	SOT – DBV	Reel of 3000	TLV2401QDBVRQ1	Product Preview		
	TSSOP – PW	Reel of 2000	TLV2404QPWRQ1	Product Preview		

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

ISTRUMENTS

⁽²⁾ Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage ⁽²⁾			17	V
V_{ID}	Differential input voltage range			±20	٧
I	Input current range (any input)			±10	mA
Io	Output current range			±10	mA
	Continuous total power dissipation	See	Dissipati	on Ratings Table	
T _A	Operating free-air temperature range	-40	125	Ĵ	
T_J	Operating virtual junction temperature			150	°C
T _{stg}	Storage temperature range		-60	125	Ĵ
		Human-Body Model (HBM)		500	
ESD	Electrostatic discharge (3)	Machine Model (MM)		200	V
		Field_Induced_Charged Device Model (CDM)		1000	
	Lead temperature 1,6 mm (1/16 inch) from ca		260	°C	

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATINGS

PACKAGE	Q _{JC} (°C/W)	Q _{JA} (°C/W)	T _A ≤ 25°C POWER RATING	TA = 125°C POWER RATING
D (8)	38.3	176	710 mW	142 mW
D (14)	26.9	122.6	1022 mW	204.4 mW
DBV (5)	55	324.1	385 mW	77.1 mW
DGK (8)	54.2	259.9	481 mW	96.2 mW
PW (14)	29.3	173.6	720 mW	144 mW

RECOMMENDED OPERATING CONDITIONS

		MIN	MAX	UNIT	
Vac	Cumply valtage	Single supply	2.5	16	V
V _{CC}	Supply voltage	Split supply	±1.25	±8	
V_{ICR}	Common-mode input voltage range		-0.1	V _{CC} +5	V
T_A	Operating free-air temperature				°C

⁽²⁾ All voltage values, except differential voltages, are with respect to GND.

⁽³⁾ Tested in accordance with AEC-Q100.

ELECTRICAL CHARACTERISTICS DC Performance

 V_{CC} = 2.7 V, 5 V, and 15 V (unless otherwise noted)

	PARAMETER	TEST	CONDITIONS	TA	MIN	TYP	MAX	UNIT
DC Peri	formance						,	
V _{IO}	Input offset voltage	$V_O = V_{CC}/2 V$, $V_{IC} =$	= V _{CC} /2 V, RS = 50 Ω	25°C Full range		390	1900 2800	μV
αV _{IO}	Offset voltage draft			25°C		3		μV/°C
			V _{CC} = 2.7 V	25°C	60	120		
				Full range	56			
		$V_{IC} = 0 \text{ to } V_{CC},$ RS = 50 Ω	$V_{CC} = 5 V$	25°C	65	120		
CMRR	Common mode rejection ratio			Full range	58			dB
			V _{CC} = 15 V	25°C	73	120		
				Full range	73			
				25°C	130	400		
		$V_{CC} = 2.7 \text{ V}, V_{O(pp)}$	Full range	12				
	Large-signal differential		25°C	300	1000		V/mV	
A_{VD}	voltage amplification	$V_{CC} = 5 \text{ V}, V_{O(pp)} =$	Full range	37				
				25°C	1000	1800		
		$V_{CC} = 15 \text{ V}, V_{O(pp)} =$	Full range	66			ļ	
Input C	haracteristics			1				
				25°C		25	250	
I _{IO}	Input offset current	- Va - Vaa/2 V Va -	= V _{CC} /2 V, RS = 50 Ω	Full range			400	pA
		VU - VCC/2 V, VIC -	- V _U 2 V, NO - 00 12	25°C		100	300	
I _{IB}	Input bias current		Full range			900	pА	
$r_{i(d)}$	Differential input resistance			25°C		300		ΜΩ
C _{i(c)}	Common-mode input capacitance	f = 100 kHz		25°C		3		pF



ELECTRICAL CHARACTERISTICS DC Performance (continued)

V_{CC} = 2.7 V, 5 V, and 15 V (unless otherwise noted)

	PARAMETER	TEST C	ONDITIONS		T _A	MIN	TYP	MAX	UNIT
Output	Characteristics								
					25°C	2.65	2.68		
			V _{CC} =2.7 V		Full range	2.63			
		V V /2			25°C	4.95	4.98		
		$V_{IC} = V_{CC}/2,$ $I_{OH} = -2 \mu A$	V _{CC} = 5 V	Full range	4.93				
					25°C	14.95	14.98		
V _{OH}	High-level output voltage		V _{CC} = 15 V		Full range	14.93			V
VOH	riigir level oalpat voltage				25°C	2.62	2.65		v
			V _{CC} = 2.7 V		Full range	2.6			
		$V_{10} = V_{00}/2$			25°C	4.92	4.95		
		$V_{IC} = V_{CC}/2,$ $I_{OH} = -50 \mu\text{A}$	V _{CC} = 5 V		Full range	4.9			
					25°C	14.92	14.95		
			V _{CC} = 15 V		Full range	14.9			
					25°C		90	150	
V _{OL}	Low-level output voltage	$V_{IC} = V_{CC}/2$, $I_{OL} = 2 \mu$	Α		Full range			180	mV
OL	3				25°C		180	230	
		$V_{IC} = V_{CC}/2, I_{OL} = 50 $	AL		Full range			260	
I _O	Output current	$V_O = 0.5 \text{ V from rail}$			25°C		±200		μΑ
Power S	Supply		T		T	T			
				25°C		880	990		
			V _{CC} =2.7 V or 5 V		Full range			1300	
I _{CC}	Supply current (per channel)	$V_O = V_{CC}/2$		25°C		900	1050	nA	
			V _{CC} = 15 V		Full range			1400	
	Reverse supply current	$V_{CC} = -18 \text{ V}, V_{IN} = 0 \text{ V}$	/, V _O = Open circ	uit	25°C		50		nA
					25°C	100	120		
PSRR	Power supply rejection ratio	$V_{CC} = 2.7 \text{ V or 5 V, V}_{I}$	$_{\rm C}$ = $V_{\rm CC}/2$, No loa	d	Full range	83			dB
PSKK	$(\Delta V_{CC}/\Delta V_{IO})$				25°C	100	120		
		$V_{CC} = 5$ to 15 V, $V_{IC} =$	V _{CC} /2, No load		Full range	97			dB
Dynami	c Performance								
UGBW	Unity gain bandwidth	$R_L = 500 \text{ k}\Omega, C_L = 100$) pF		25°C		5.5		kHz
SR Slew rate at unity gain					25°C		2.5		V/ms
φΜ	Phase margin	$R_L = 500 \text{ k}\Omega, C_L = 100$) nF		25°C		60°		
	Gain margin	11 <u>C</u> = 000 122, O <u>C</u> = 100	, bi	1	20 0		15		dB
		$V_{CC} = 2.7 \text{ V or 5 V},$ $V_{(STEP)PP} = 1 \text{ V},$ $A_{V} = -1,$	$C_L = 100 \text{ pF}$ $R_L = 100 \text{ k}\Omega$	0.1%			1.84		
t _S	Settling time	$A_{V} = -1,$ $V_{CC} = 15 \text{ V},$	0 :55 -	0.1%	25°C		6.1		ms
		$V_{(STEP)PP} = 1 V,$ $A_V = -1,$	$C_L = 100 \text{ pF}$ $R_L = 100 \text{ k}\Omega$	0.01%			32		



ELECTRICAL CHARACTERISTICS DC Performance (continued)

 $V_{CC} = 2.7 \text{ V}$, 5 V, and 15 V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T _A	MIN	TYP	MAX	UNIT
Nois	se/Distortion Performance						
.,	Equivalent input paige valtage	f = 10 Hz			800		nV/√ Hz
V _n	Equivalent input noise voltage	f = 100 Hz	25°C		500		nv/vHz
In	Equivalent input noise current	f = 100 Hz			8		fA/√ Hz



TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
V _{IO}	Input Offset Voltage	vs Common-mode input voltage	Figure 1, Figure 2, Figure 3
I _{IB}	Innut Biog Current	vs Free-air temperature	Figure 4, Figure 6, Figure 8
	Input Bias Current	vs Common-mode input voltage	Figure 5, Figure 7, Figure 9
I _{IO}	land Office Comment	vs Free-air temperature	Figure 4, Figure 6, Figure 8
	Input Offset Current	vs Common-mode input voltage	Figure 5, Figure 7, Figure 9
CMRR	Common-mode rejection ratio	vs Frequency	Figure 10
V _{OH}	High-level output voltage	vs High-level output current	Figure 11, Figure 13, Figure 15
V _{OL}	Low-level output voltage	vs Low-level output current	Figure 12, Figure 14, Figure 16
V _{O(PP)}	Output voltage peak-to-peak	vs Frequency	Figure 17
Z _o	Output impedance	vs Frequency	Figure 18
I _{CC}	Supply current	vs Supply voltage	Figure 19
PSRR	Power supply rejection ratio	vs Frequency	Figure 20
A _{VD}	Differential voltage gain	vs Frequency	Figure 21
	Phase	vs Frequency	Figure 21
	Gain-bandwidth product	vs Supply voltage	Figure 22
	SR Slew rate	vs Free-air temperature	Figure 23
φm	Phase margin	vs Capacitive load	Figure 24
	Gain margin	vs Capacitive load	Figure 25
	Supply current	vs Reverse voltage	Figure 26
	Voltage noise over a 10 Second Period		Figure 27
	Large signal follower pulse response		Figure 28, Figure 29, Figure 30
	Small signal follower pulse response		Figure 31
	Large signal inverting pulse response		Figure 32, Figure 33, Figure 34
	Small signal inverting pulse response		Figure 35
	Crosstalk	vs Frequency	Figure 36





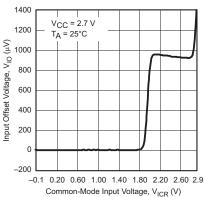


Figure 1.

INPUT OFFSET VOLTAGE vs COMMON-MODE INPUT VOLTAGE

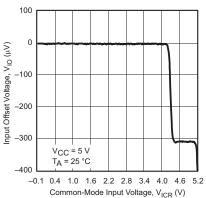


Figure 2.

INPUT OFFSET VOLTAGE vs COMMON-MODE INPUT VOLTAGE

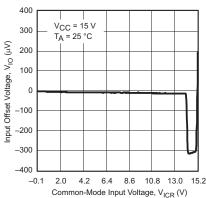


Figure 3.

INPUT BIAS / OFFSET CURRENT vs FREE-AIR TEMPERATURE

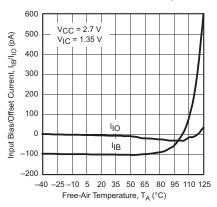


Figure 4.

INPUT BIAS / OFFSET CURRENT vs COMMON MODE INPUT VOLTAGE

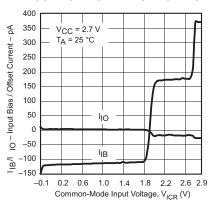


Figure 5.

INPUT BIAS / OFFSET CURRENT vs FREE-AIR TEMPERATURE

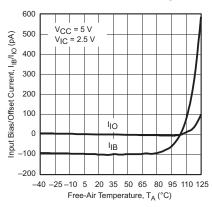


Figure 6.

INPUT BIAS / OFFSET CURRENT vs COMMON-MODE INPUT VOLTAGE

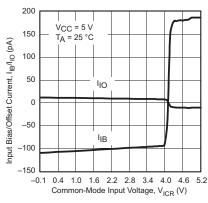


Figure 7.

INPUT BIAS / OFFSET CURRENT vs

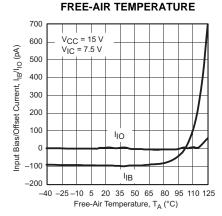


Figure 8.

INPUT BIAS / OFFSET CURRENT vs COMMON-MODE INPUT VOLTAGE

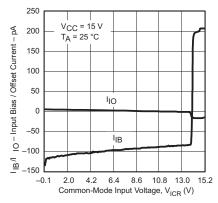


Figure 9.



COMMON-MODE REJECTION RATIO vs

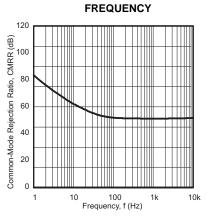


Figure 10.

HIGH-LEVEL OUTPUT VOLTAGE vs HIGH-LEVEL OUTPUT CURRENT

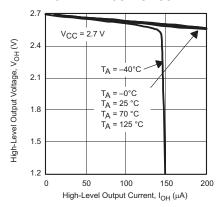


Figure 11.

LOW-LEVEL OUTPUT VOLTAGE vs LOW-LEVEL OUTPUT CURRENT

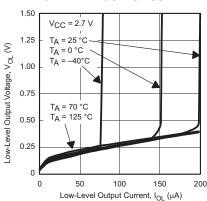


Figure 12.

HIGH-LEVEL OUTPUT VOLTAGE vs HIGH-LEVEL OUTPUT CURRENT

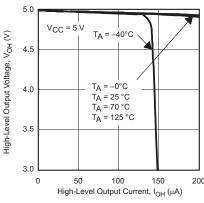


Figure 13.

LOW-LEVEL OUTPUT VOLTAGE

vs

LOW-LEVEL OUTPUT CURRENT

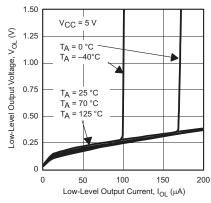


Figure 14.

HIGH-LEVEL OUTPUT VOLTAGE

vs

HIGH-LEVEL OUTPUT CURRENT

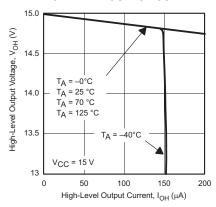


Figure 15.

LOW-LEVEL OUTPUT VOLTAGE vs LOW-LEVEL OUTPUT CURRENT

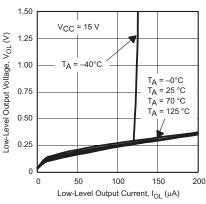


Figure 16.

OUTPUT VOLTAGE PEAK-TO-PEAK vs FREQUENCY

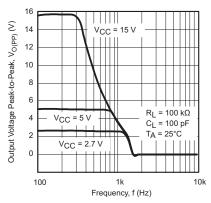


Figure 17.

OUTPUT IMPEDANCE vs

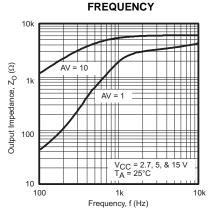


Figure 18.



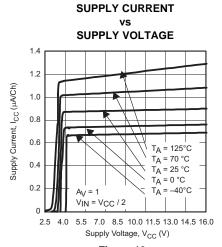


Figure 19.

DIFFERENTIAL VOLTAGE GAIN AND PHASE

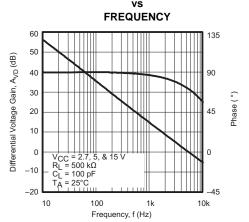


Figure 21.

SLEW RATE vs FREE-AIR TEMPERATURE

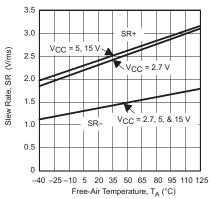


Figure 23.

POWER SUPPLY REJECTION RATIO vs FREQUENCY

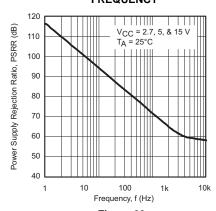


Figure 20.

GAIN BANDWIDTH PRODUCT vs SUPPLY VOLTAGE

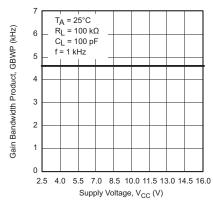


Figure 22.

PHASE MARGIN vs CAPACITIVE LOAD

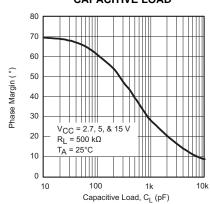


Figure 24.



 www.ti.com
 SLOS716 – APRIL 2011

GAIN MARGIN vs Capacitive Load

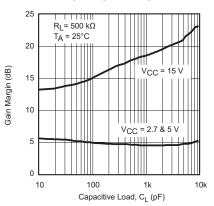


Figure 25.

VOLTAGE NOISE OVER A 10 SECOND PERIOD

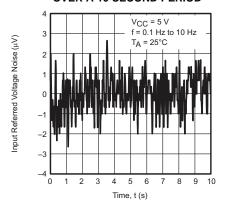


Figure 27.

LARGE SIGNAL FOLLOWER PULSE RESPONSE

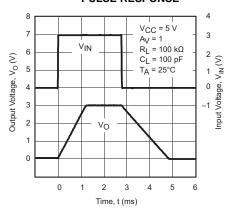


Figure 29.

SUPPLY CURRENT vs REVERSE VOLTAGE

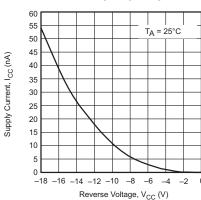


Figure 26.

LARGE SIGNAL FOLLOWER PULSE RESPONSE

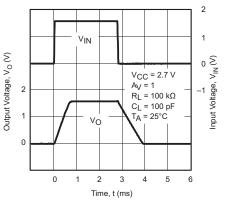


Figure 28.

LARGE SIGNAL FOLLOWER PULSE RESPONSE

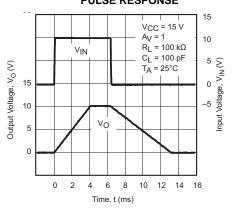


Figure 30.



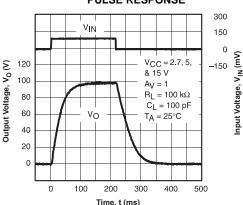


Figure 31.

LARGE SIGNAL INVERTING PULSE RESPONSE

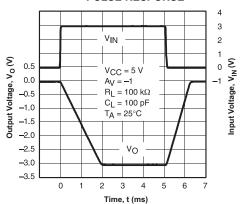


Figure 33.

SMALL SIGNAL INVERTING PULSE RESPONSE

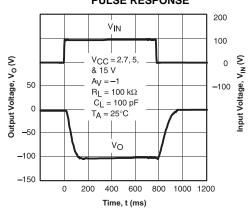


Figure 35.

LARGE SIGNAL INVERTING PULSE RESPONSE

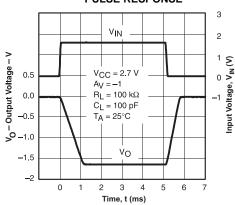


Figure 32.

LARGE SIGNAL INVERTING PULSE RESPONSE

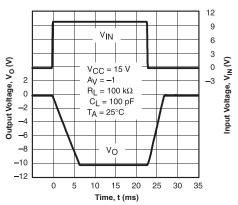


Figure 34.

CROSSTALK vs FREQUENCY

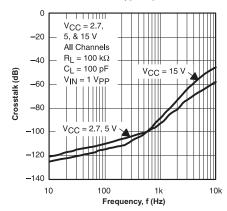


Figure 36.



APPLICATION INFORMATION

Reverse Battery Protection

The TLV240x-Q1 are protected against reverse battery voltage up to 18 V. When subjected to reverse battery condition the supply current is typically less than 100 nA at 25°C (inputs grounded and outputs open). This current is determined by the leakage of 6 Schottky diodes and will therefore increase as the ambient temperature increases.

When subjected to reverse battery conditions and negative voltages applied to the inputs or outputs, the input ESD structure will turn on—this current should be limited to less than 10 mA. If the inputs or outputs are referred to ground, rather than midrail, no extra precautions need be taken.

Common-Mode Input Range

The TLV240x-Q1 has rail-to-rail input and outputs. For common-mode inputs from -0.1 V to $\text{V}_{\text{CC}} - 0.8 \text{ V}$ a PNP differential pair will provide the gain.

For inputs between $V_{CC} - 0.8 \text{ V}$ and V_{CC} , two NPN emitter followers buffering a second PNP differential pair provide the gain. This special combination of NPN/PNP differential pair enables the inputs to be taken 5 V above the rails, because as the inputs go above V_{CC} , the NPNs switch from functioning as transistors to functioning as diodes. This will lead to an increase in input bias current. The second PNP differential pair continues to function normally as the inputs exceed V_{CC} .

The TLV240x-Q1 has a negative common-input range that exceeds ground by 100 mV. If the inputs are taken much below this, reduced open loop gain will be observed with the ultimate possibility of phase inversion.

Offset Voltage

The output offset voltage, (V_{OO}) is the sum of the input offset voltage (V_{IO}) and both input bias currents (I_{IB}) times the corresponding gains. The following schematic and formula can be used to calculate the output offset voltage:

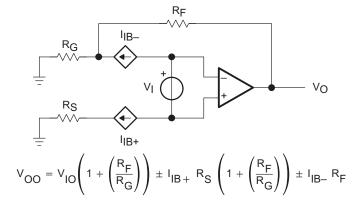


Figure 37. Output Offset Voltage Model

General Configurations

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. The simplest way to accomplish this is to place an RC filter at the noninverting terminal of the amplifier (see Figure 38).

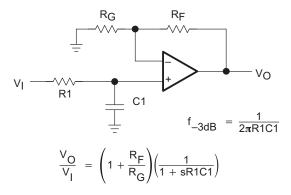


Figure 38. Single-Pole Low-Pass Filter

If even more attenuation is needed, a multiple pole filter is required. The Sallen-Key filter can be used for this task. For best results, the amplifier should have a bandwidth that is 8 to 10 times the filter frequency bandwidth. Failure to do this can result in phase shift of the amplifier.

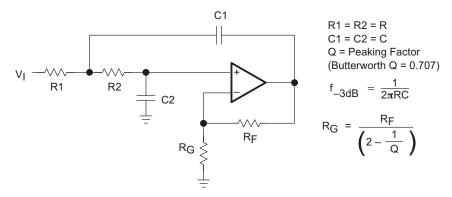


Figure 39. 2-Pole Low-Pass Sallen-Key Filter

NSTRUMENTS



Circuit Layout Considerations

To achieve the levels of high performance of the TLV240x-Q1, follow proper printed-circuit board design techniques. A general set of guidelines is given in the following.

- Ground planes It is highly recommended that a ground plane be used on the board to provide all components with a low inductive ground connection. However, in the areas of the amplifier inputs and output, the ground plane can be removed to minimize the stray capacitance.
- Proper power supply decoupling Use a 6.8-mF tantalum capacitor in parallel with a 0.1-mF ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1-mF ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1-mF capacitor should be placed as close as possible to the supply terminal. As this distance increases, the inductance in the connecting trace makes the capacitor less effective. The designer should strive for distances of less than 0.1 inches between the device power terminals and the ceramic capacitors.
- Sockets Sockets can be used but are not recommended. The additional lead inductance in the socket pins
 will often lead to stability problems. Surface-mount packages soldered directly to the printed-circuit board is
 the best implementation.
- Short trace runs/compact part placements Optimum high performance is achieved when stray series
 inductance has been minimized. To realize this, the circuit layout should be made as compact as possible,
 thereby minimizing the length of all trace runs. Particular attention should be paid to the inverting input of the
 amplifier. Its length should be kept as short as possible. This will help to minimize stray capacitance at the
 input of the amplifier.
- Surface-mount passive components Using surface-mount passive components is recommended for high
 performance amplifier circuits for several reasons. First, because of the extremely low lead inductance of
 surface-mount components, the problem with stray series inductance is greatly reduced. Second, the small
 size of surface-mount components naturally leads to a more compact layout thereby minimizing both stray
 inductance and capacitance. If leaded components are used, it is recommended that the lead lengths be kept
 as short as possible.

TEXAS INSTRUMENTS

SLOS716 – APRIL 2011 www.ti.com

General Power Dissipation Considerations

For a given θ_{JA} , the maximum power dissipation is shown in Figure 40 and is calculated by the following formula:

$$P_{D} = \left(\frac{T_{MAX}^{-T}A}{\theta_{JA}}\right)$$

Where:

PD = Maximum power dissipation of THS240x IC (watts)

T_{MAX}= Absolute maximum junction temperature (150°C)

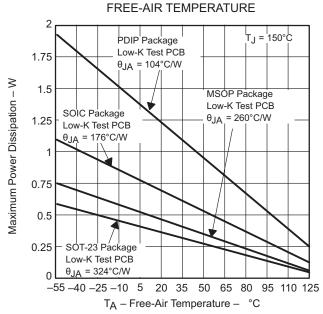
 T_A = Free-ambient air temperature (°C)

$$\theta_{JA} = \theta_{JC} + \theta_{CA}$$

 θ_{JC} = Thermal coefficient from junction to case

 θ_{CA} = Thermal coefficient from case to ambient air (°C/W)

MAXIMUM POWER DISSIPATION vs



(1) Results are with no air flow and using JEDEC Standard Low-K test PCB.

Figure 40. Maximum Power Dissipation vs Free-Air Temperature



Macromodel Information

Macromodel information provided was derived using Microsim PartsE Release 8, the model generation software used with Microsim PSpiceE. The Boyle macromodel⁽¹⁾ and subcircuit in Figure 41 are generated using the TLV240x-Q1 typical electrical and operating characteristics at $T_A = 25^{\circ}$ C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- · Maximum positive output voltage swing
- · Maximum negative output voltage swing
- · Slew rate
- Quiescent power dissipation
- · Input bias current
- · Open-loop voltage amplification
- · Unity-gain frequency
- Common-mode rejection ratio
- · Phase margin
- · DC output resistance
- AC output resistance
- · Short-circuit output current limit

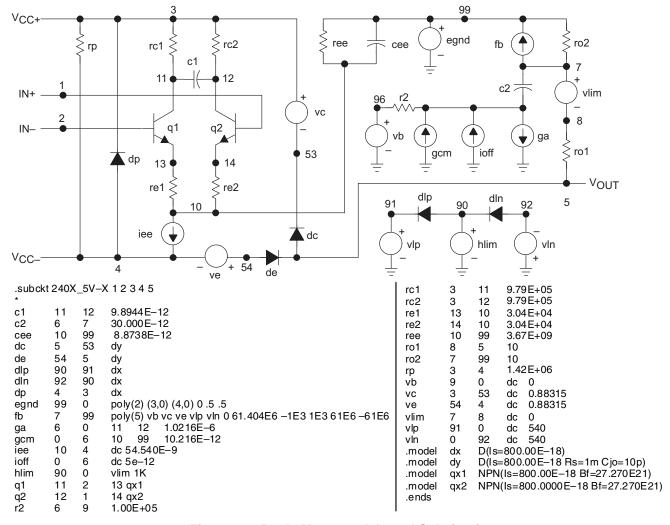


Figure 41. Boyle Macromodels and Subcircuit

(1) G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", IEEE Journal of Solid-State Circuits, SC-9, 353 (1974).

16-Aug-2012

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
TLV2402QDGKRQ1	ACTIVE	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL. Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TLV2402-Q1:

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

16-Aug-2012 www.ti.com

TAPE AND REEL INFORMATION

REEL DIMENSIONS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width							
В0	Dimension designed to accommodate the component length							
K0	Dimension designed to accommodate the component thickness							
W	Overall width of the carrier tape							
P1	Pitch between successive cavity centers							

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLV2402QDGKRQ1	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 16-Aug-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLV2402QDGKRQ1	VSSOP	DGK	8	2500	358.0	335.0	35.0

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46C and to discontinue any product or service per JESD48B. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

roducts	Applications	
udia	ununu ti com/ou dio	Automotivo on

Audio Automotive and Transportation www.ti.com/automotive www.ti.com/audio www.ti.com/communications **Amplifiers** amplifier.ti.com Communications and Telecom **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** Consumer Electronics www.ti.com/consumer-apps www.dlp.com DSP dsp.ti.com **Energy and Lighting** www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical Logic logic.ti.com Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

OMAP Mobile Processors www.ti.com/omap TI E2E Community e2e.ti.com

Wireless Connectivity www.ti.com/wirelessconnectivity

www.ti-rfid.com

Pr